

Notice of References Cited	Application/Control No. 10/771,449		Applicant(s)/Patent Under Reexamination IWAI ET AL.	
	Examiner Sujatha Sharma		Art Unit 2618	Page 2 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6885880	04-2005	Ali	
*	B	US-20030210206	11-2003	Phillips et al.	
	C	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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